Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/659,567	EGNOR ET AL.	
Examiner	Art Unit	
Erin M. File	2611	

	SEARCHED				
Class	Subclass	Date	Examiner		
375	341	9/29/2006	EMF		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (text search only—see search history printout)	9/29/2006	EMF
PALM INVENTORSHIP	9/29/2006	EMF
PLUS Search	9/29/2006	EMF
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